

# SLOVENSKI STANDARD

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**Elektromagnetna združljivost (EMC) - 4-3. del: Preskusne in merilne tehnike -  
Preskušanje odpornosti proti sevanim radiofrekvenčnim elektromagnetnim poljem**

Electromagnetic compatibility (EMC) - Part 4-3: Testing and measurement techniques -  
Radiated, radiofrequency, electromagnetic field immunity test

Elektromagnetische Verträglichkeit (EMV) - Teil 4-3: Prüf- und Messverfahren - Prüfung  
der Störfestigkeit gegen hochfrequente elektromagnetische Felder

Compatibilité électromagnétique (CEM) - Partie 4-3 : Techniques d'essai et de mesure -  
Essai d'immunité aux champs électromagnétiques rayonnés aux fréquences  
radioélectriques

**Ta slovenski standard je istoveten z: EN IEC 61000-4-3:2020**

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EUROPEAN STANDARD

**EN IEC 61000-4-3**

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Supersedes EN 61000-4-3:2006, EN 61000-4-3:2006/IS1:2009 and all of its amendments and corrigenda (if any)

English Version

**Electromagnetic compatibility (EMC) - Part 4-3 : Testing and measurement techniques - Radiated, radio-frequency, electromagnetic field immunity test (IEC 61000-4-3:2020)**

Compatibilité électromagnétique (CEM) - Partie 4-3 :  
Techniques d'essai et de mesure - Essai d'immunité aux  
champs électromagnétiques rayonnés aux fréquences  
radioélectriques  
(IEC 61000-4-3:2020)

Elektromagnetische Verträglichkeit (EMV) - Teil 4-3: Prüf-  
und Messverfahren - Prüfung der Störfestigkeit gegen  
hochfrequente elektromagnetische Felder  
(IEC 61000-4-3:2020)

This European Standard was approved by CENELEC on 2020-10-13. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the CEN-CENELEC Management Centre or to any CENELEC member.

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European Committee for Electrotechnical Standardization  
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**CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels**

**EN IEC 61000-4-3:2020 (E)****European foreword**

The text of document 77B/830/FDIS, future edition 4 of IEC 61000-4-3, prepared by SC 77B "High frequency phenomena" of IEC/TC 77 "Electromagnetic compatibility" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 61000-4-3:2020.

The following dates are fixed:

- latest date by which the document has to be implemented at national (dop) 2021-07-13 level by publication of an identical national standard or by endorsement
- latest date by which the national standards conflicting with the (dow) 2023-10-13 document have to be withdrawn

This document supersedes EN 61000-4-3:2006 and all of its amendments and corrigenda (if any).

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. CENELEC shall not be held responsible for identifying any or all such patent rights.

This document has been prepared under a mandate given to CENELEC by the European Commission and the European Free Trade Association.

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The text of the International Standard IEC 61000-4-3:2020 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 61000-4 series	NOTE	Harmonized as EN 61000-4 series
IEC 61000-4-6	NOTE	Harmonized as EN 61000-4-6
IEC 61000-4-20:2010	NOTE	Harmonized as EN 61000-4-20:2010 (not modified)
IEC 61000-4-21	NOTE	Harmonized as EN 61000-4-21
IEC 61000-4-22	NOTE	Harmonized as EN 61000-4-22
IEC 61000-4-39	NOTE	Harmonized as EN 61000-4-39
CISPR 16-1-4	NOTE	Harmonized as EN IEC 55016-1-4

## Annex ZA (normative)

### Normative references to international publications with their corresponding European publications

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: [www.cenelec.eu](http://www.cenelec.eu).

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60050-161	-	International Electrotechnical Vocabulary. Chapter 161: Electromagnetic compatibility	-	-

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IEC 61000-4-3

Edition 4.0 2020-09

# INTERNATIONAL STANDARD



**Electromagnetic compatibility (EMC) –  
Part 4-3: Testing and measurement techniques – Radiated, radio-frequency  
electromagnetic field immunity test**

SIST EN IEC 61000-4-3:2021

<https://standards.iteh.ai/catalog/standards/sist/76a2cd0b-bca2-44f5-971e-ba6ad8fa11e7/sist-en-iec-61000-4-3-2021>

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## INTERNATIONAL ELECTROTECHNICAL COMMISSION

**ELECTROMAGNETIC COMPATIBILITY (EMC) –****Part 4-3: Testing and measurement techniques –  
Radiated, radio-frequency electromagnetic field immunity test**

## FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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International Standard IEC 61000-4-3 has been prepared by subcommittee 77B: High frequency phenomena, of IEC technical committee 77: Electromagnetic compatibility.

It forms part 4-3 of IEC 61000. It has the status of a basic EMC publication in accordance with IEC Guide 107.

This fourth edition cancels and replaces the third edition published in 2006, Amendment 1:2007 and Amendment 2:2010. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) testing using multiple test signals has been described;
- b) additional information on EUT and cable layout has been added;
- c) the upper frequency limitation has been removed to take account of new services;
- d) the characterization of the field as well as the checking of power amplifier linearity of the immunity chain are specified.

The text of this International Standard is based on the following documents:

FDIS	Report on voting
77B/830/FDIS	77B/825/RVD

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61000 series, published under the general title *Electromagnetic compatibility (EMC)*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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## INTRODUCTION

IEC 61000 is published in separate parts according to the following structure:

**Part 1: General**

General considerations (introduction, fundamental principles)  
Definitions, terminology

**Part 2: Environment**

Description of the environment  
Classification of the environment  
Compatibility levels

**Part 3: Limits**

Emission limits  
Immunity limits (in so far as they do not fall under the responsibility of the product committees)

**Part 4: Testing and measurement techniques**

Measurement techniques  
Testing techniques

**Part 5: Installation and mitigation guidelines**

Installation guidelines  
Mitigation methods and devices

**Part 6: Generic standards**

**Part 9: Miscellaneous**

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Each part is further subdivided into several parts, published either as international standards or as technical specifications or technical reports, some of which have already been published as sections. Others will be published with the part number followed by a dash and a second number identifying the subdivision (example: IEC 61000-6-1).

This part is an international standard which gives immunity requirements and test procedures related to radiated, radio-frequency, electromagnetic fields.

## ELECTROMAGNETIC COMPATIBILITY (EMC) –

### Part 4-3: Testing and measurement techniques – Radiated, radio-frequency electromagnetic field immunity test

#### 1 Scope

This part of IEC 61000 is applicable to the immunity requirements of electrical and electronic equipment to radiated electromagnetic energy. It establishes test levels and the required test procedures.

The object of this document is to establish a common reference for evaluating the immunity of electrical and electronic equipment when subjected to radiated, radio-frequency electromagnetic fields. The test method documented in this part of IEC 61000 describes a consistent method to assess the immunity of an equipment or system against RF electromagnetic fields from RF sources not in close proximity to the EUT. The test environment is specified in Clause 6.

NOTE 1 As described in IEC Guide 107, this is a basic EMC publication for use by product committees of the IEC. As also stated in Guide 107, the IEC product committees are responsible for determining whether this immunity test standard should be applied or not, and if applied, they are responsible for determining the appropriate test levels and performance criteria. TC 77 and its sub-committees are prepared to co-operate with product committees in the evaluation of the value of particular immunity tests for their products.

NOTE 2 Immunity testing against RF sources in close proximity to the EUT is defined in IEC 61000-4-39.

Particular considerations are devoted to the protection against radio-frequency emissions from digital radiotelephones and other RF emitting devices.

NOTE 3 Test methods are defined in this part for evaluating the effect that electromagnetic radiation has on the equipment concerned. The simulation and measurement of electromagnetic radiation is not adequately exact for quantitative determination of effects. The test methods defined in this basic document have the primary objective of establishing an adequate reproducibility of testing configuration and repeatability of test results at various test facilities.

This document is an independent test method. It is not possible to use other test methods as substitutes for claiming compliance with this document.

#### 2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-161, *International Electrotechnical Vocabulary (IEV) – Part 161: Electromagnetic compatibility* (available at [www.electropedia.org](http://www.electropedia.org))

#### 3 Terms, definitions and abbreviated terms

##### 3.1 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 60050-161 and the following apply.